

Application/Control No.	Applicant(s)/Patent under Reexamination
10/719,924	BAUM ET AL.
Examiner	Art Unit
Benjamin Kurtz	1723

	SEAR	CHED	
Class	Subclass	Date	Examiner
210	85,87,93 96.1,101 198.1,199 259	9/20/2006	вк
	205,219	9/20/2006	вк
	754,759	9/20/2006	вк
	163,164	9/20/2006	ВК
	143	9/20/2006	ВК
422	28,37,62	9/20/2006	ВК
	105,108	9/20/2006	ВК
	110,111	9/20/2006	ВК
137	88	9/20/2006	ВК
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
1					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Classification search from Primary Joe Drodge	9/20/2006	вк		
Classification search from Primary Terry Cecil	9/20/2006	вк		
Classification search form Primary John Kim	9/20/2006	вк		
Inventor Name search .	4/10/2007	BK		
Updated Search	4/10/2007	ВК		